

## **ACCURACY & SIMPLICITY**

THAT SHOW THE DIFFERENCES BETWEEN SURFACES

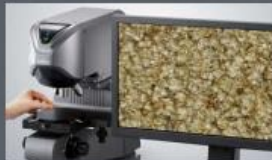
**16-BIT  
LASER MICROSCOPE OFFERS  
MANY ADVANTAGES  
OTHERWISE IMPOSSIBLE**



**EASY & FAST**

HIGH-RESOLUTION COLOR OBSERVATION  
WITHOUT PRE-PROCESSING

- 16-bit colour observation
- No pre-processing or vacuuming required
- No restrictions on samples



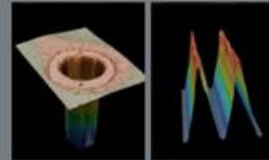
**With SEMs**  
Because vacuuming is required, it takes time before starting observation. While there are restrictions on samples, observation is possible only in monochrome.



**NO RESTRICTIONS  
ON TARGETS**

HIGH-ACCURACY MEASUREMENT WITH  
PINHOLE CONFOCAL SYSTEM

- Measures even steep shapes with low noise
- Can measure even inclined samples
- High horizontal resolution



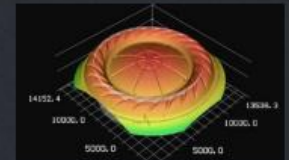
**With optical interferometers**  
Measurement is difficult except for surfaces that reflect light strongly. In addition to this poor angle characteristic, inclination correction is required and the horizontal resolution is the same as with optical microscopes.



**NON-CONTACT  
MEASUREMENT**

HIGH-ACCURACY  
LASER SCANNING

- No damage to targets
- Instance measurement of desired position
- Laser spot diameter of 0.2  $\mu\text{m}$



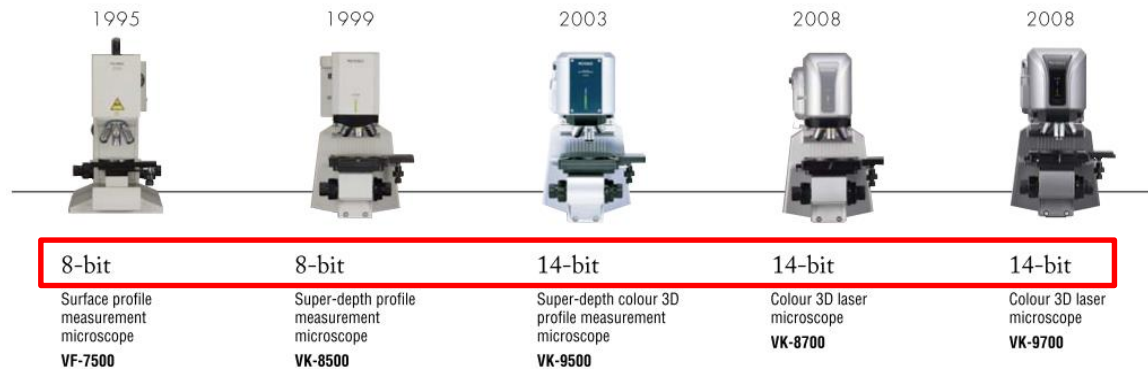
**With roughness meters**  
There are various restrictions and limitations on measurement, including limitations on targets due to the measurement method that brings a needle into contact with the sample surface.

# ADVANCED LASER MICROSCOPE

16-bit Shape Analysis Laser Microscope: VK-X260/X160/X130 Series



## HISTORY OF LASER SCANNING MICROSCOPES



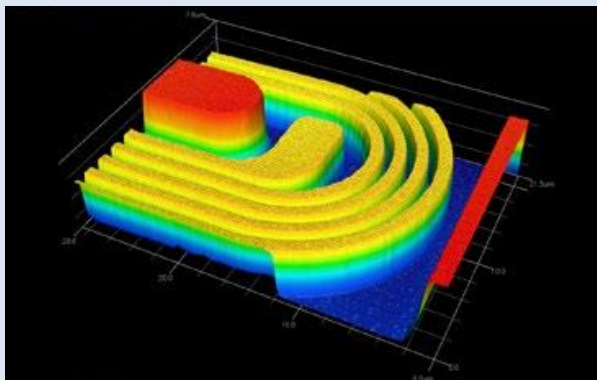
## High-resolution/High-Magnification observation

As with color SEMs, high versatility is provided with high-resolution, fully-focused images and X/Y dimension measurement to support traceability.



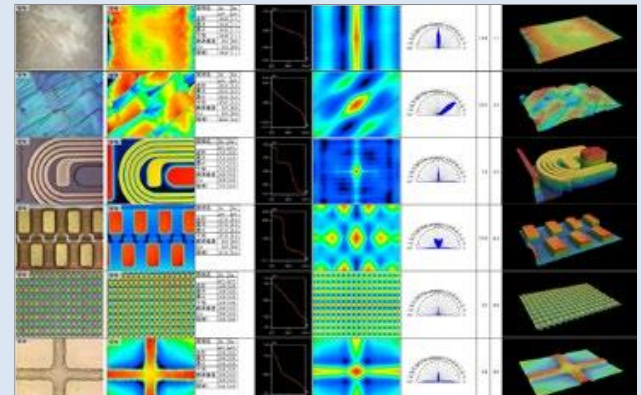
## Highest Accuracy in the industry

Our original sensing technologies have improved the laser sensitivity by 16 times over conventional models



## Fully-Automatic Measurement

Automatic recognition of the shape and material of a sample produces consistent measurement results.



# High-resolution/High-Magnification observation

Super High-resolution Observation and True Color

Equipped with a 21.6 megapixel, 3CCD camera

Built-in camera with 3CCD imaging mode  
Record up to a **21.6 megapixel image**



## What is the pixel shift method?

Records a total of 9 images by shifting the CCD both vertically and horizontally by 1/3 of a pixel. Furthermore, it obtains RGB data for each pixel, thus allowing for clear observation with superior colour reproduction.

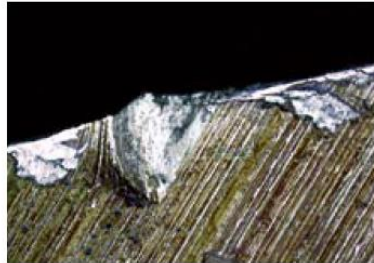
Fully focused images even at high magnification

## HIGH-SPEED DEPTH COMPOSITION FUNCTION/ AUTO FOCUS

OPTICAL IMAGE



DEPTH COMPOSITION IMAGE

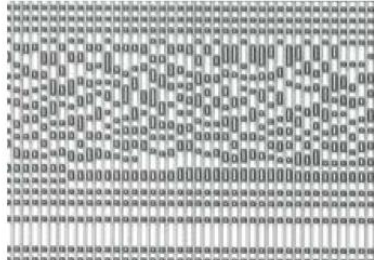


Blade edge (1000x)

OPTICAL IMAGE



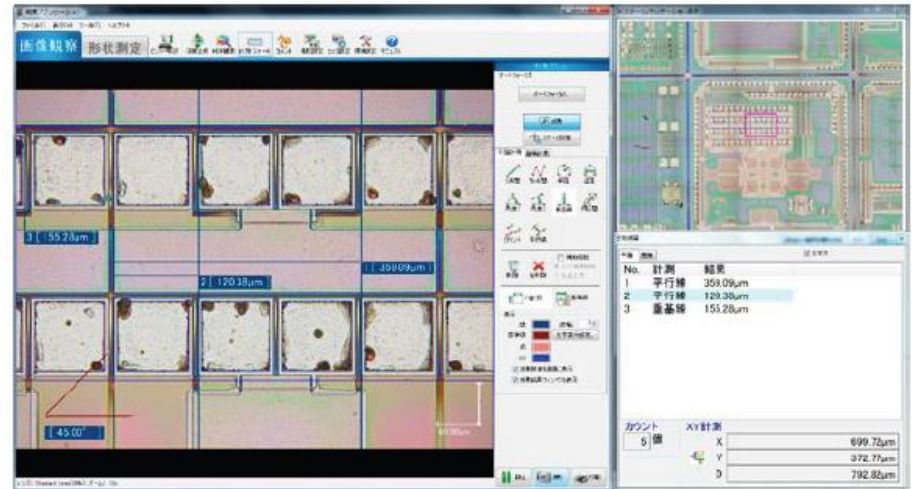
LASER IMAGE



Disk pits (6000x)

Real-time measurement on screen

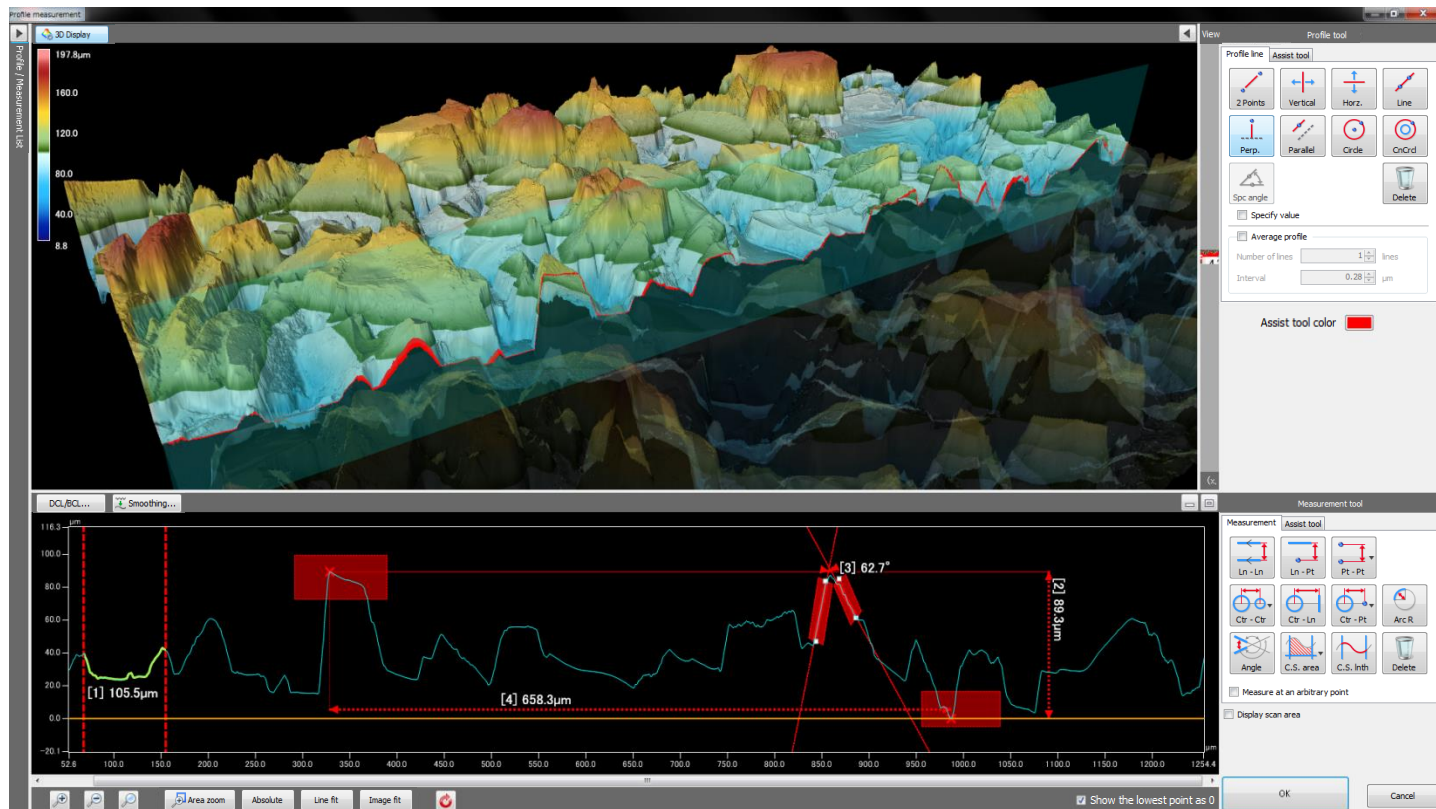
## X/Y DIMENSION MEASUREMENT (TRACEABILITY SUPPORT)



## Instantaneous scanning of shapes with laser

Laser x 16 bits =

# HIGH-ACCURACY 3D MEASUREMENT



# High-resolution/High-Magnification observation

## < Problems of measuring instrument users

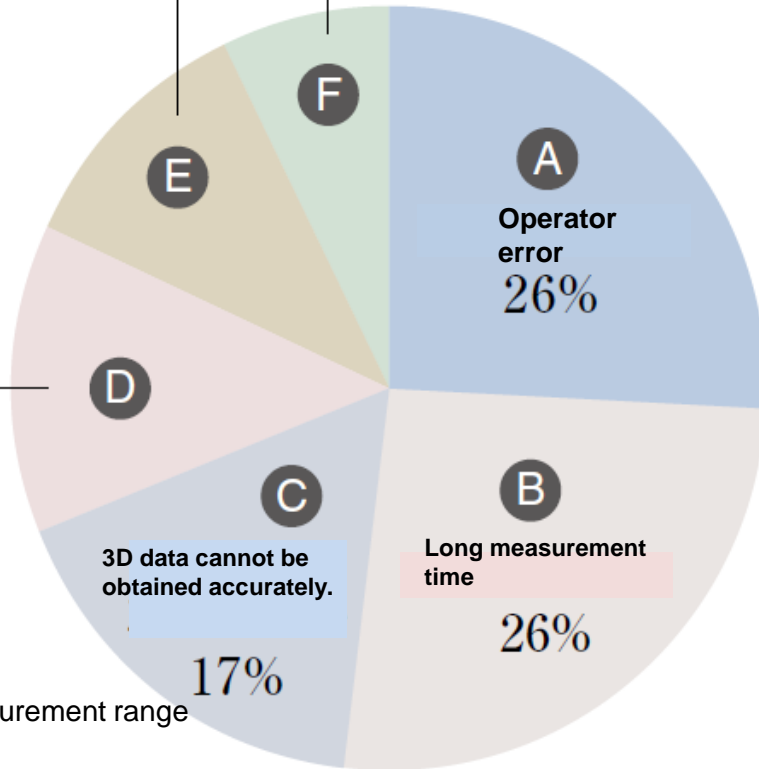
> Investigation performed by KEYENCE

Samples cannot be placed on the stage.

Insufficient resolution

11%

7%



3D data cannot be obtained accurately.

Long measurement time

17%

26%

Narrow measurement range

13%

World's first

## FULLY-AUTOMATIC MEASUREMENT AI-SCAN

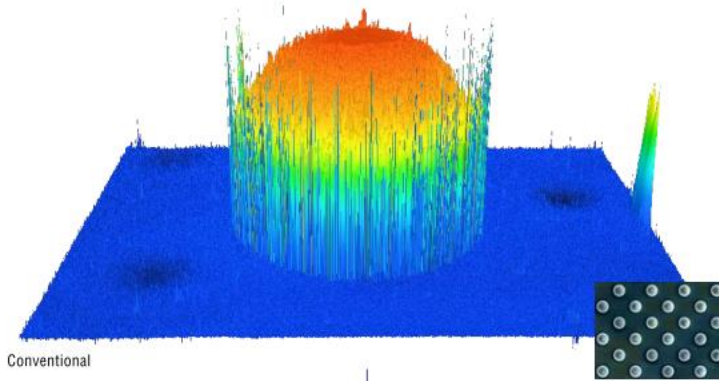
Simple clicking achieves the same measurement as experienced operators

Start measurement

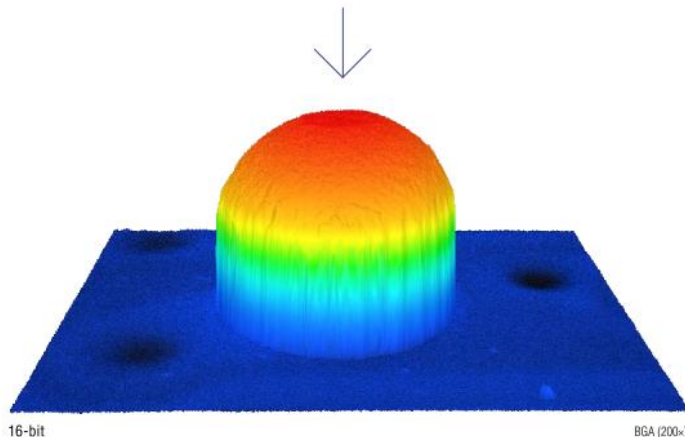


## Highest Accuracy in the Industry

# 16-BIT SENSING

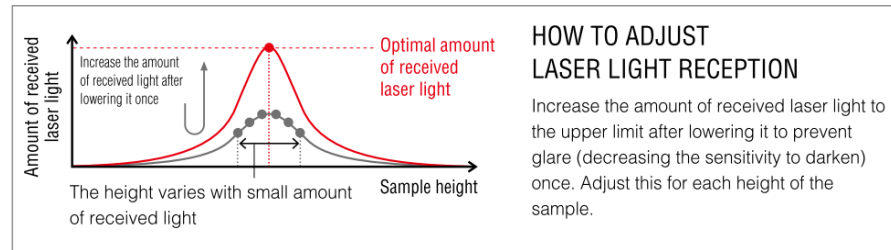


CAN MEASURE WHAT USED TO BE IMPOSSIBLE



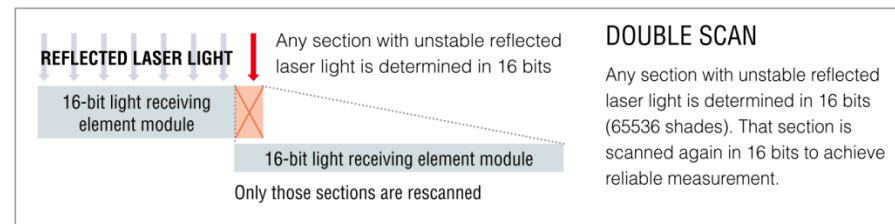
Optimally adjusts laser light intensity (AI-Scan support function 1)

## AAGII FUNCTION (AAG = ADVANCED AUTO GAIN)



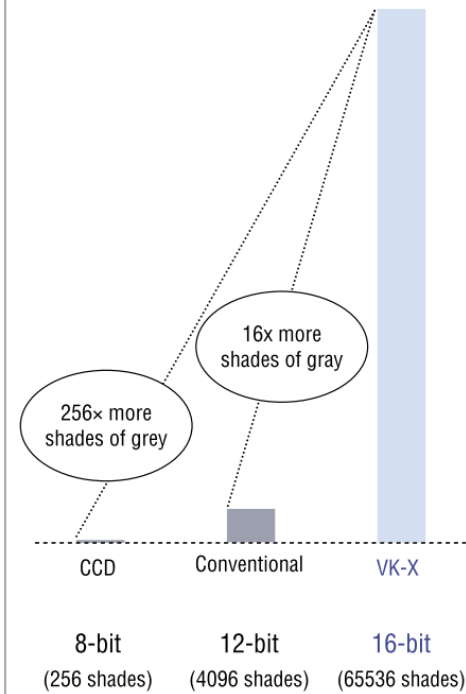
Reliable measurement with double scan (AI-Scan support function 2)

## DOUBLE SCAN FUNCTION



# Highest Accuracy in the industry

## PERFORMANCE DIFFERENCES AMONG LIGHT RECEIVING ELEMENTS



Takes further advantage of 16 bits

## EXTENSIVE LENS LINEUP



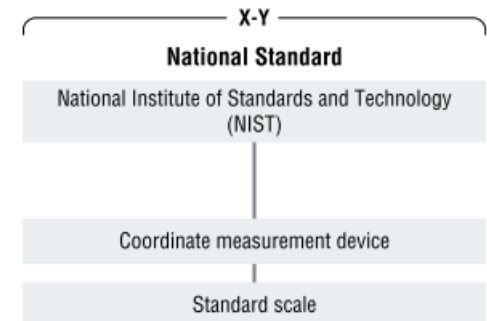
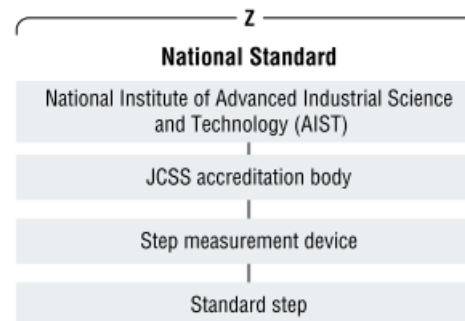
Fluorite having low refraction and colour aberration used as the lens material



Comprehensive lineup including lenses with long working distances for setting samples at a safe distance

Examples of lenses with long working distances	Monitor magnification	Working distance
Standard 5x lens	100x	22.5 mm
Ultra-long range 20x lens	400x	20.5 mm
Ultra-long range 50x lens	1000x	13.8 mm
Ultra-long range 100x lens	2000x	4.7 mm

## TRACEABILITY SYSTEM

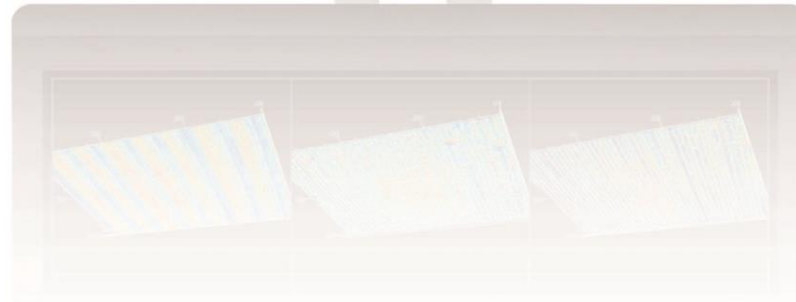
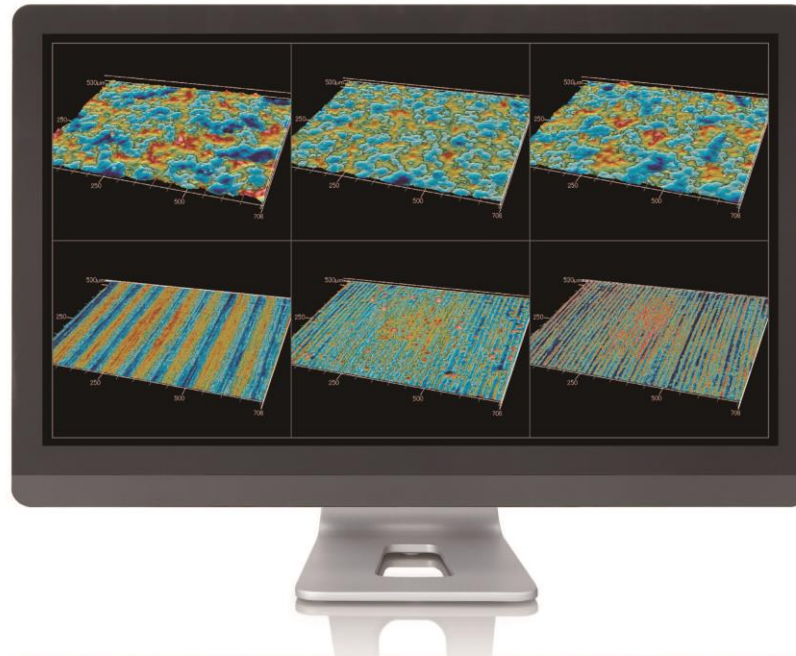


CAN MEASURE FROM A DISTANCE



## ANALYSIS AUTOMATION TOOL AI-ANALYSER

SHOWS THE DIFFERENCES YOU NEED TO KNOW

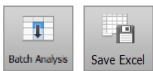
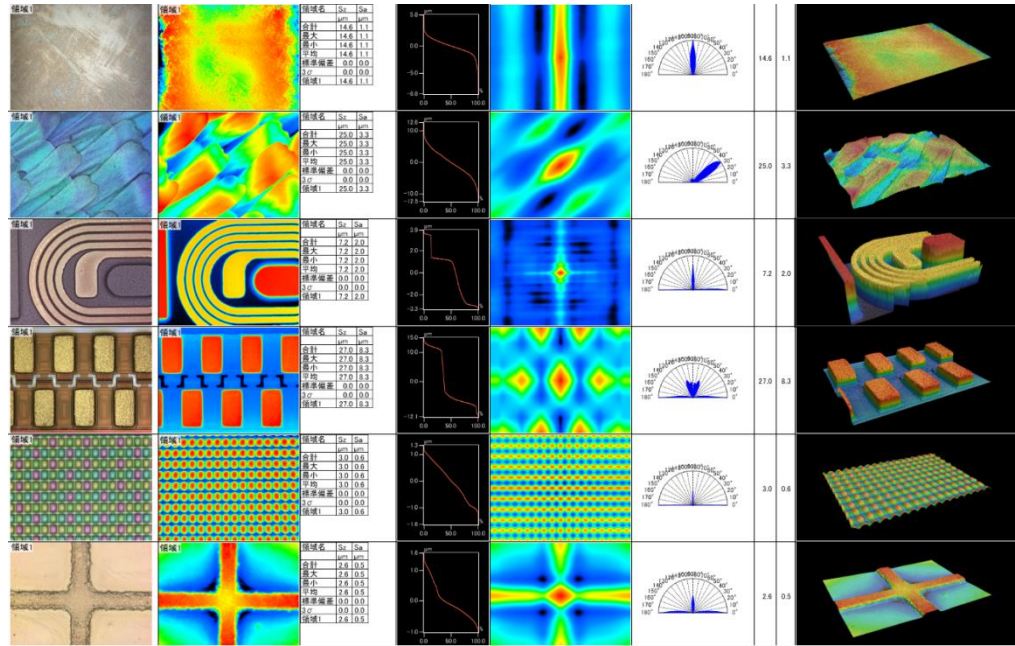
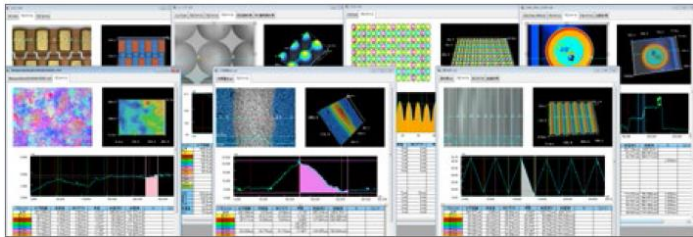


# Fully-Automatic Measurement



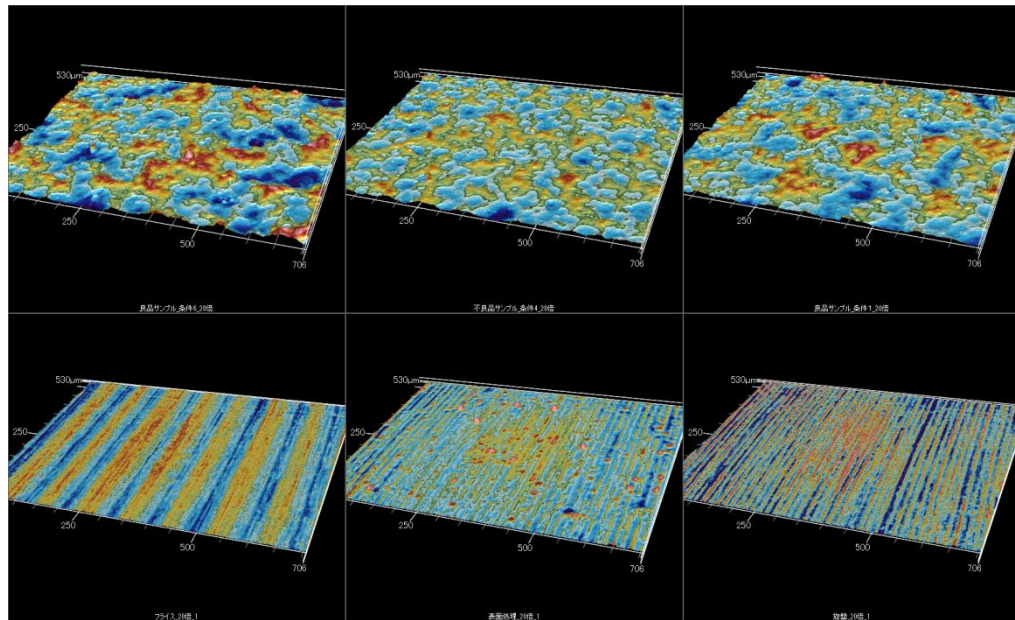
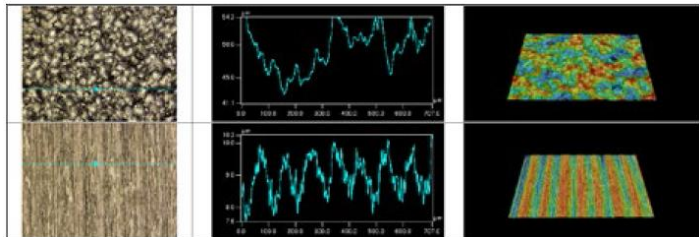
ARRANGES AND SHOWS MULTIPLE FILES  
**MULTI-FILE VIEW**

Separate result outputs require longer analysis time and hinder understanding. Their summarization in Excel also takes time.



COLLECTIVE ANALYSIS OF MULTIPLE FILES  
**AUTO ARRANGE**

Due to an unaligned height range, it cannot tell visually which projections and depressions are greater. Measurement positions differ between two files.



# Fully-Automatic Measurement



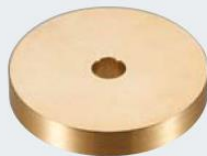
EASY TO UNDERSTAND SAMPLE ROUGHNESS VARIANCE INDICES

## ROUGHNESS PARAMETER SUGGEST

OK sample: Ra = 1.8



NG sample: Ra = 1.8



For different appearance and touch, it cannot be determined which roughness parameters to use for evaluation. Neither Ra nor Rz reveals differences.

